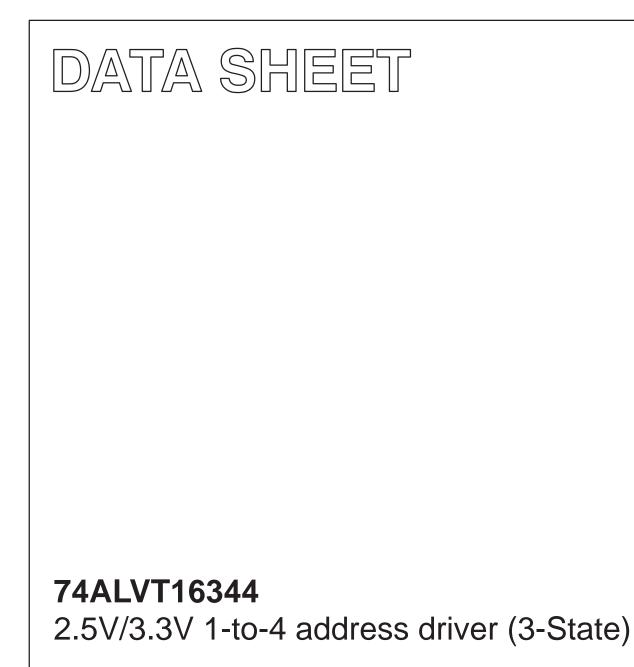
INTEGRATED CIRCUITS



Product specification IC24 Data Handbook 1998 Jun 30

PHILIPS

74ALVT16344

FEATURES

- Multiple V_{CC} and GND pins minimize switching noise
- 5V I/O Compatible
- Live insertion/extraction permitted
- 3-State output buffers
- Power-up 3-State
- Output capability: +64mA/-32mA
- Latch-up protection exceeds 500mA per Jedec JC40.2 Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model

DESCRIPTION

The 74ALVT16344 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive. It is designed for V_{CC} operation at 2.5V or 3.3V with I/O compatibility to 5V.

The 74ALVT16344 is a 1-to-4 address driver used in applications where four separate memory locations must be addressed by a single address.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYPI	UNIT	
STMBOL		T _{amb} = 25℃	2.5V	3.3V	UNIT
t _{PLH} t _{PHL}	Propagation delay nAx to nBx or nBx to nAx	C _L = 50pF	2.5 1.9	1.9 1.6	ns
C _{IN}	Input capacitance DIR, OE	$V_I = 0V \text{ or } V_{CC}$	3	3	pF
C _{Out} Output capacitance		$V_{I/O} = 0V \text{ or } V_{CC}$	9	9	pF
I _{CCZ}	Total supply current	Outputs disabled	40	70	μΑ

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
56-Pin Plastic SSOP Type III	–40°C to +85°C	74ALVT16344 DL	AV16344 DL	SOT371-1
56-Pin Plastic TSSOP Type II	–40°C to +85°C	74ALVT16344 DGG	AV16344 DGG	SOT364-1

PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
8, 14, 15, 21, 36, 42, 43, 49	nA	Data inputs
2, 3, 5, 6, 9, 10, 12, 13, 16, 17, 19, 20, 23, 24, 26, 27, 30,31, 33, 34, 37, 38, 40, 44, 45, 47, 48, 51, 52, 54, 55,	3, 34, 37, 38, 40, 44, 45, nY _X Data outputs	
1, 28, 29, 56	ŌĒ	Output enable inputs (active-Low)
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)
7, 22, 35, 50	V _{CC}	Positive supply voltage

74ALVT16344

OE1	1		56	OE4
1Y0	2		55	8Y0
1Y1	3		54	8Y1
GND	4		53	GND
1Y2	5		52	8Y2
1Y3	6		51	8Y3
V _{CC}	7		50	V _{CC}
1A	8		49	8A
2Y0	9		48	7Y0
2Y1	10		47	7Y1
GND	11		46	GND
2Y2	12		45	7Y2
2Y3	13		44	7Y3
2A	14		43	7A
ЗА	15		42	6A
3Y0	16		41	6Y0
3Y1	17		40	6Y1
GND	18		39	GND
3Y2	19		38	6Y2
3Y3	20		37	6Y3
4A	21		36	5A
V _{CC}	22		35	V _{CC}
4Y0	23		34	5Y0
4Y1	24		33	5Y1
GND	25		32	GND
4Y2	26		31	5Y2
4Y3	27	1 1	30	5Y3
OE2	28		29	OE3
			SV	01735

PIN CONFIGURATION

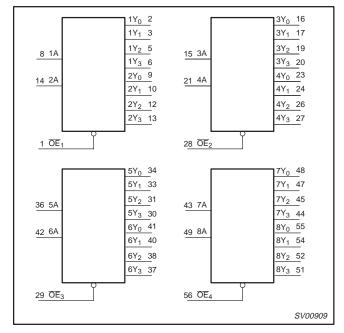
FUNCTION TABLE

INPL	JTS	OUTPUTS	OPERATING MODE	
OE	nA	nYx		
L	L	L	Transparent	
L	Н	Н	Transparent	
Н	Х	Z	High impedance	

X = Don't care Z = High impedance "off" state H = High voltage level

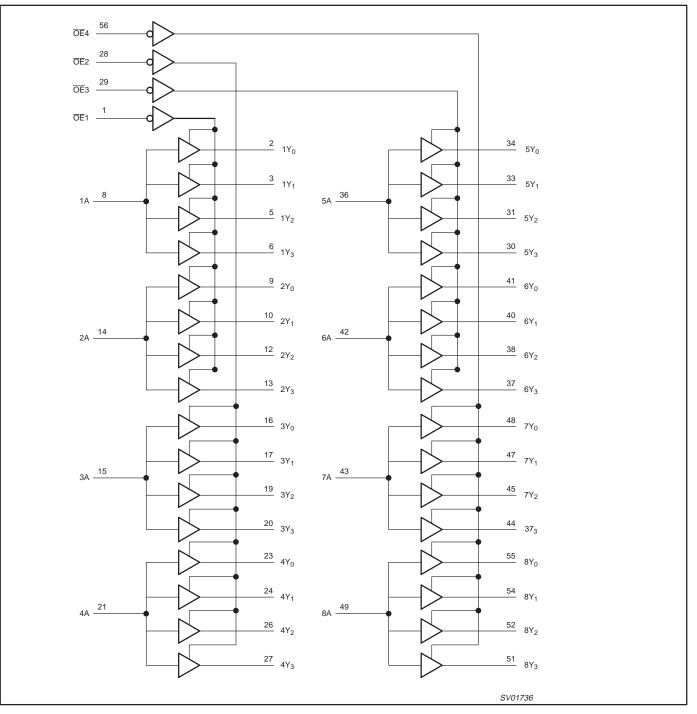
L = Low voltage level

LOGIC SYMBOL



74ALVT16344

LOGIC DIAGRAM



74ALVT16344

ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V ₁ < 0	-50	mA
VI	DC input voltage ³		-0.5 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +7.0	V
1		Output in Low state	128	mA
OUT	DC output current	Output in High state	-64	
T _{stq}	Storage temperature range		-65 to +150	°C

NOTES:

 Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	2.5V RAN	GE LIMITS	3.3V RANGE LIMITS		UNIT
STMBOL	FARAMETER		MAX	MIN	MAX	UNIT
V _{CC}	DC supply voltage	2.3	2.7	3.0	3.6	V
VI	Input voltage	0	5.5	0	5.5	V
V _{IH}	V _{IH} High-level input voltage			2.0		V
V _{IL}	Input voltage		0.7		0.8	V
I _{OH}	High-level output current		-8		-32	mA
le.	Low-level output current		8		32	mA
IOL	Low-level output current; current duty cycle \leq 50%; f \geq 1kHz		24		64	ШA
Δt/Δv	$\Delta t / \Delta v$ Input transition rise or fall rate; Outputs enabled		10		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	-40	+85	°C

74ALVT16344

DC ELECTRICAL CHARACTERISTICS (3.3V ± 0.3V RANGE)

					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS		Temp = ·	-40°C to	+85°C	UNIT
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	$V_{CC} = 3.0V; I_{IK} = -18mA$			-0.85	-1.2	V
M	High-level output voltage	$V_{CC} = 3.0$ to 3.6V; $I_{OH} = -100\mu A$		V _{CC} -0.2	V _{CC}		
V _{OH}	l lightevel output voltage	$V_{CC} = 3.0V; I_{OH} = -32mA$		2.0	2.3		1
		V _{CC} = 3.0V; I _{OL} = 100µA			0.07	0.2	
V _{OL}	Low-level output voltage	V _{CC} = 3.0V; I _{OL} = 16mA			0.25	0.4	V
		V _{CC} = 3.0V; I _{OL} = 32mA			0.3	0.5	1
		V _{CC} = 3.0V; I _{OL} = 64mA			0.4	0.55	1
		$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } GND$	Control ning		0.1	±1	
	Input leakage current	V _{CC} = 0 or 3.6V; V _I = 5.5V	Control pins		0.1	10	
I _I		$V_{CC} = 3.6V; V_{I} = 5.5V$			0.1	10	μA
		$V_{CC} = 3.6V; V_I = V_{CC}$	Data pins ⁴		0.1	1	
		$V_{CC} = 3.6V; V_{I} = 0$			0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$			0.1	±100	μA
	Bus Hold current	$V_{CC} = 3V; V_{I} = 0.8V$		75	130		μA
I _{HOLD}		$V_{CC} = 3V; V_I = 2.0V$		-75	-200		μA
	A or B outputs	$V_{\rm I} = 0V$ to 3.6V; $V_{\rm CC} = 3.6V^6$		±500			μA
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	V _O = 5.5V; V _{CC} = 3.0V			10	125	μA
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2$ V; $V_O = 0.5$ V to V_{CC} ; $V_I = GND OE/OE = Don't care$) or V _{CC} ;		1	±100	μA
I _{OZH}	3-State output High current	$V_{CC} = 3.6V; V_{O} = 3.0V; V_{I} = V_{IL} \text{ or } V_{IH}$			0.5	5	μA
I _{OZL}	3-State output Low current	$V_{CC} = 3.6V; V_{O} = 0.5V; V_{I} = V_{IL} \text{ or } V_{IH}$			0.5	-5	μA
ICCH		V_{CC} = 3.6V; Outputs High, V_{I} = GND or V	V _{CC} , I _{O =} 0		0.06	0.1	
I _{CCL}	Quiescent supply current	V_{CC} = 3.6V; Outputs Low, V_{I} = GND or V	$V_{\rm CC, I_{\rm O}=0}$		7	8.5	mA
I _{CCZ}	1	V _{CC} = 3.6V; Outputs Disabled; V _I = GND) or V_{CC} , $I_{O} = 0^5$		0.06	0.1	1
ΔI_{CC}	Additional supply current per input pin ²	$V_{CC} = 3V$ to 3.6V; One input at V_{CC} -0.6° Other inputs at V_{CC} or GND	V,		0.05	0.4	mA

NOTES:

All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C.
This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 3.3V ± 0.3V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.

Unused pins at V_{CC} or GND. 4.

I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
This is the bus hold overdrive current required to force the input to the opposite state.

AC CHARACTERISTICS (3.3V ± 0.3V RANGE)

GND = 0V, $t_R = t_F = 2.5ns$, $C_L = 50pF$, $R_L = 500\Omega$

				LIMITS		
SYMBOL	PARAMETER	WAVEFORM	T _{amb} = -40 to +85°C V _{CC} = +3.3V ±0.3V		UNIT	
			MIN	TYP	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	1.9 1.6	3.0 2.5	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	2	1.0 1.0	2.8 2.3	4.7 3.6	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.0 1.0	3.7 2.3	5.5 4.1	ns

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DC ELECTRICAL CHARACTERISTICS (2.5V \pm 0.2V RANGE)

				LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS		Temp =	-40°C to	+85°C	
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	$V_{CC} = 2.3V; I_{IK} = -18mA$			-0.85	-1.2	V
V _{OH}	High-level output voltage	$V_{CC} = 2.3$ to 2.7V; $I_{OH} = -100\mu A$		V _{CC} -0.2	V _{CC}		v
VОН	nigh-level output voltage	$V_{CC} = 2.3V; I_{OH} = -8mA$		1.7	2.1		v
Vol	Low-level output voltage	$V_{CC} = 2.3V; I_{OL} = 100\mu A$			0.07	0.2	v
VOL	Low-level output voltage	$V_{CC} = 2.3V; I_{OL} = 24mA$			0.3	0.5	v
		$V_{CC} = 2.7V$; $V_I = V_{CC}$ or GND	Control pins		0.1	±1	
		$V_{CC} = 0 \text{ or } 2.7 \text{V}; \text{ V}_{\text{I}} = 5.5 \text{V}$	Control pins		0.1	10	
I _I	Input leakage current	$V_{CC} = 2.7V; V_{I} = 5.5V$			0.1	10	μA
		$V_{CC} = 2.7V; V_{I} = V_{CC}$	Data pins ⁴		0.1	1	
		$V_{CC} = 2.7V; V_I = 0$	1		0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V$; V_{I} or $V_{O} = 0$ to 4.5V			0.1	±100	μA
I _{HOLD} 6	Bus Hold current	$V_{CC} = 2.5V; V_{I} = 0.8V$			105		μA
	A inputs	$V_{CC} = 2.5V; V_I = 2.0V$			10		μΑ
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	V _O = 5.5V; V _{CC} = 2.3V			10	125	μA
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2$ V; $V_O = 0.5$ V to V_{CC} ; $V_I = GNE OE/OE = Don't care$	D or V _{CC}		1	100	μA
I _{OZH}	3-State output High current	V_{CC} = 2.7V; V_{O} = 2.3V; V_{I} = V_{IL} or V_{IH}			0.5	5	μA
I _{OZL}	3-State output Low current	V_{CC} = 2.7V; V_{O} = 0.5V; V_{I} = V_{IL} or V_{IH}			0.5	-5	μA
I _{CCH}		$V_{CC} = 2.7V$; Outputs High, $V_I = GND$ or	V_{CC} , $I_{O} = 0$		0.04	0.1	
I _{CCL}	Quiescent supply current	$V_{CC} = 2.7V$; Outputs Low, $V_I = GND$ or V_I	$I_{\rm CC, I_{\rm O} = 0}$		5.0	6.5	mA
I _{CCZ}]	V_{CC} = 2.7V; Outputs Disabled; V_I = GND	0 or $V_{CC, I_{O}} = 0^5$		0.04	0.1	
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 2.3V to 2.7V; One input at $V_{CC}\text{0}$ Other inputs at V_{CC} or GND	.6V,		0.04	0.4	mA

NOTES:

All typical values are at V_{CC} = 2.5V and T_{amb} = 25°C.
This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 2.5V ± 0.2V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.
Unused pins at V_{CC} or GND.
I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
Not guaranteed.

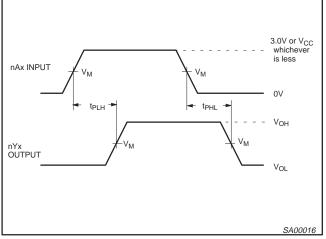
AC CHARACTERISTICS (2.5V \pm 0.2V RANGE) GND = 0V, t_R = t_F = 2.5ns, C_L = 50pF, R_L = 500 Ω

				LIMITS		
SYMBOL	PARAMETER	WAVEFORM	T _{amb} = -40 to +85°C V _{CC} = +2.5V ±0.2V		UNIT	
			MIN	TYP	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	2.5 1.9	4.2 3.9	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	2	1.0 1.0	3.5 2.8	6.1 4.6	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low level	2	1.0 1.0	2.8 3.1	5.3 4.9	ns

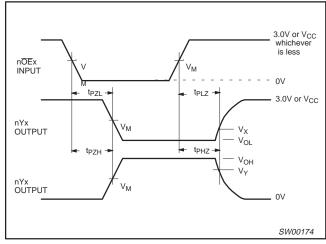
74ALVT16344

AC WAVEFORMS

 $\begin{array}{l} V_{M} = 1.5V \mbox{ for } V_{CC} \geq 3.0V; \mbox{ } V_{M} = V_{CC}/2 \mbox{ for } V_{CC} \leq 2.7V \\ V_{X} = V_{OL} + 0.3V \mbox{ for } V_{CC} \geq 3.0V; \mbox{ } V_{X} = V_{OL} + 0.15V \mbox{ for } V_{CC} \leq 2.7V \\ V_{Y} = V_{OH} - 0.3V \mbox{ for } V_{CC} \geq 3.0V; \mbox{ } V_{Y} = V_{OH} - 0.15V \mbox{ for } V_{CC} \leq 2.7V \\ \end{array}$

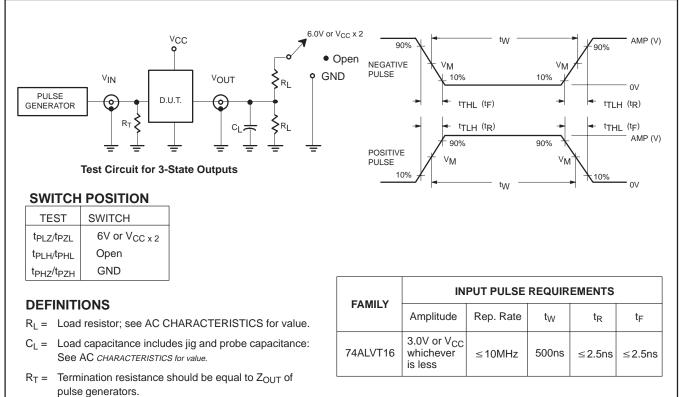


Waveform 1. Input (nAx) to Output (nYx) Propagation Delays



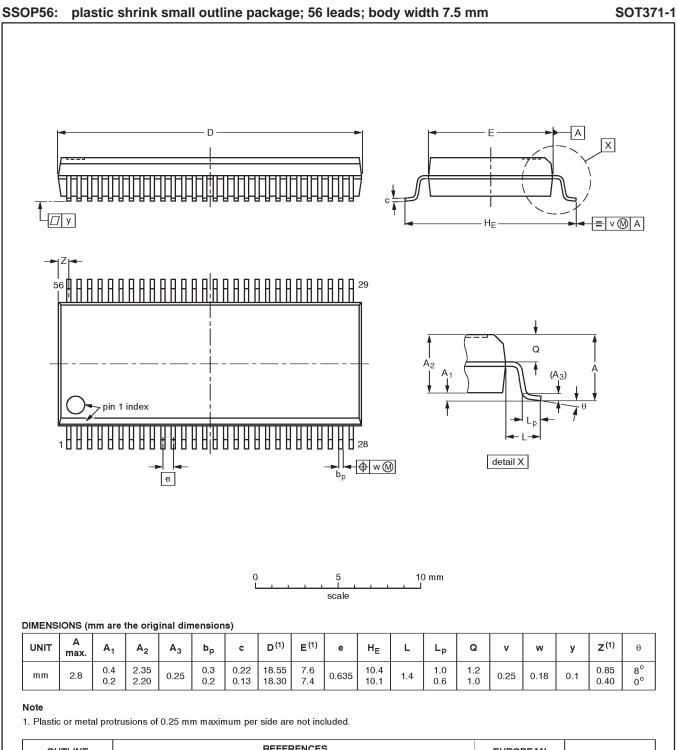
Waveform 2. 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORM



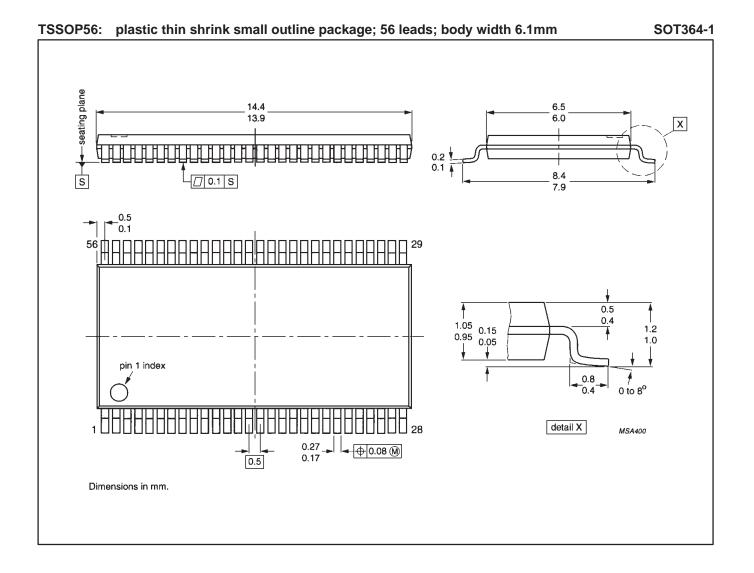
SW00205

74ALVT16344



OUTLINE		REFERENCES			EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	1550E DATE
SOT371-1		MO-118AB				-93-11-02 95-02-04

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NOTES

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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Limiting values definition - Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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